

# **Progress TU/e**

Progress Meeting OpenPICs 04/04/2018



#### Where innovation starts





## Work Package 1

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WP1.M1	Demonstrator definitions – linking products to building blocks	Aura	Mar-17
WP1.M2	Survey of requirements and building blocks	Weiming	Nov-18
WP1.M3	Platform roadmap	Aura	Sep-18
WP1.M4	Key performance Indicators for MPWs	Aura	Sep-17
WP1.M5	Training and Outreach	Aura	Jun-17



Milestone (WP1.M4): Key Performance Indicators for MPW runs (KPIs)

Authors: Aura Higuera Rodriguez

Due date:	31/09/2017
Actual Submission Date:	18/12/2017
Lead Partner:	PITC-TU/e
Contributing Partners:	-

#### Summary

Open access technology platforms exist as a solution for PIC prototyping
on a fab-less lab-less model. They provide cheap fabrication entry costs
and relatively simple chip design process for first entry designers. They
target public and privat sector for SMEs and big companies.
The ecosystem surrounding open access technology platforms include
research, design, software tools and foundries. Foundries are a critical
module within the ecosystem since they develop the technology for the
platforms to fabricate the chips. Therefore, the MPW runs need to comply
with several KPIs in order to be competitive as a PIC entry fabrication
service. Those KPIs will be described in this document.

#### Table of Contents

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- KPIs in JePPIX Roadmap
- JePPIX Training Eindhoven 2017
- JePPIX Training Beijing 2018

### Work Package 3









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### **Building Block Design Bright**, Tue



MPW run #							SP18	SP19	SP	20	SP21	SP22	SP23	SP24	SP25	SP26	SP27	SP28	SP29
Month								12 1 3	2 3 4	5 6	78	9 10 11 1	2 1 2	3 4 5	5 6 7 8 9 10 11		12 1 2 3 4 5		6 7 8
ID	Title	Responsible	Contrib. partner	Due Times			2016			2	2017			201			201		
WP 3.1	BB Design																		
WP3.1.M0	Technology and Design Concept	Weiming, Ronald		🔵 Dec-17				postpo	ned fro	om Brig	ght								
WP3.1.R0	Analysis and Design	Weiming, Ronald		🔵 Dec-17						p	ostpone	d from Bri	ght						
WP3.1.M1	Mask Design Tape-out I	Weiming, Ronald		🔵 Jun-17								Y							
WP3.1.R1	BB Results I	Weiming, Ronald		🔵 Mar-18															
WP3.1.M2	Mask Design Tape-out II	Weiming, Ronald		Sep-18															
WP3.1.R2	BB Results II	Weiming, Ronald		🔵 Jun-19															

- High-speed modulator
- RF Lines
- Spot-size converter
- Low linewidth laser
- Precision filter

30 GHz EO bandwidth, moderate eye diagram 20 Gb/s 67+ GHz bandwidth, BCB spacing layer await information from Smart **Bright Photonics Bright Photonics** 

20 Gb/s alibrate.



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WP3.1.

M1

#### PDK Content Smart, TUe



MPW run #						SP18	SP19	) SF	P20	SP21	SP22	SP23	SP24	SP25	SP26	SP27	SP28	SP29	
Month						9 10 11	12 1	2 3	4 5 6	6 7 8	9 10 11 1	12 1 2	3 4 5	6 7 8	9 10 11	12 1 2	3 4 5	6 7	3
ID	Title	Responsible	Contrib. partner	Due Times		2016			2	2017				2018			2019		
WP 3.2	PDK Content																		
WP3.2.M0	State of the PDK	Rui		Dec-16															
WP3.2.M1	Definition of basic BB figure of merits	Rui		🔵 Mar-17															
WP3.2.M2	Definition of composite BB FoM	Weiming		🔵 Mar-17															
WP3.2.R0	Definition of measurement procedures	Weiming		🔵 Jun-17									<b>_</b>						
WP3.2.R1	PDK upgrade with new advanced BB	Rui		🔵 Mar-18															
WP3.2.R2	Compact Models	Rui		🔵 Jun-18															

- State of the PDK
- Listing of Figure of merits
- Composite BB Figure of Merits
- Test cell measurement procedures
- Introduction of advanced BBs

Smart PDK release 2017 used to design BB test cells used to design CBB test cell deliverable describing those

Interface definition based on GDS or JSON









MPW run #							SP18	SP19	SP20	SP21	SP22	SP23	SP24	SP25	SP26	SP27	SP28	SP29		
Month								9 10 11 12 1 2 3 4 5 6 7 8 9 10 11 12 1 2 3 4 5 6 7 8 9 10 11 12 1 2 3 4 5 6 7 8 9 10 11 12 1 2 3 4 5 6												
ID	Title Responsible Contrib. partner Due Times						2016 2017						2018					2019		
WP 3.3	BB Characterization																			
WP3.3.R0	Design of Standard MPW BB test cell	Weiming		🔵 Mar-17																
WP3.3.M0	Report on standard MPW BB cell results	Rui		Every MPW																
WP3.3.R1	Design of composite BB test cell	Weiming		🔵 Sep-17									_							
WP3.3.M1	Report on composite test cell results	Weiming		Mar-18																

- Design of BB test cell
- Composite BB test cell
- Automation work
- Report on BB testing
- Testing of cBB

compatible with automated test layout list of advanced BBs from TU/e (SP22) automated test setup -> May 2018

joint effort with Smart SP22 delayed





## **BB Test Cell Results**

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### SP 20 spectral gain



SP 20 shallow WG Ring resonator with source-detector



### SP19 Metal Resistance



**Figure 6.** Comparison of extracted values and calculation. We introduce uncertainties in the thickness because the precise value in SP19 is unknown. Left data point represents evaporated+sputtered metal and right data point with plating.





(b) Figure 3. SEM cross section of (a) sputtered metal over deep trench and (b) with electro-plating in SP19 samples.

- Report in WP3.3.M0
- Re-design test cell for next run
- Faster testing with automated die testing









← Layerstack fixed, wafer growth to start in mid- April)

 $\leftarrow$  Serious issues with reproducibility



### **Work Package 4**



← In idle, waiting for MPW layout from SMART to continue...

← Demonstrated earlier. Report to be written.



# **Highlights: Zn diffusion uniformity (3")**



- Diffusion front variation ~ 140nm (single diffusion)
- Causes might include:
  - Lower temperature in wafer center (faster diffusion)
  - Non-uniformity in layers thicknesses



### **Highlights: MaN process for stepper**



Picture 1a/b: SEM images of undercut profile of 2 microns for Ma-N 1420.



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# Demonstrator/Milestones Actions Any Other Business

**OpenPICs** Confidential







## Reports

### Form of documenting partner effort

Output of project

- Technical Content in form of gathered data, insight
- →increases usefulness

Reuse encouraged

→ Tutorial, templates...



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MPW run #						SP18	SP19	SP20	SP21	SP22	SP23	SP24	SP25	SP26	SP27	SP28	SP29
Month						9 10 11	12 1 2	3 4 5	6 7 8	9 10 11	12 1 2	3 4 5	6 7 8	9 10 11	12 1 2	3 4 5	6 7 8
ID	Title	Responsible	Contrib. partner	Due Times		2016			2017				2018			2019	
WP 3.5	Demonstrator Design																
WP3.5.R0	400G Transmitter concept	Saeed		🔵 Mar-17													
WP3.5.R1	Fiber sensing chip concept	Pim		🔵 Mar-17													
WP3.5.M0	400 G Transmitter Design	Saeed		Sep-18													
WP3.5.M1	Fiber Sensing Chip Design	Ronald		Sep-18													
WP3.5.M2	Results of 400G Transmitter	Saeed		🔵 Jun-19													
WP3.5.M3	Results of fiber sensing chip	Pim		🔵 Jun-19													

Demonstrator Design ready in September!

### **Fiber Sensor Chip** Technobis+Bright

### **400 G Transmitter** Effect







## **Actions/AOB**

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- Effect Demonstrator decision on which run, what BBs (Saeed coordinates)
- Technobis Demonstrator which run, SSC, tolerances, linewidth (Ronald coordinates)
- SSC more data needed
- Input for Phoenix requested from all partners
  - Way to define DRC
  - Way to define BB, PDK
  - Smart performs evaluation with example PDK
  - Version control
- Next Meeting Location

